## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination LEE, KIL SUO | Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,253,415 A	03-1981	Ferch, Alois	116/63P
	В	US-4,978,207 A	12-1990	Gillner et al.	359/871
	С	US-5,023,607 A	06-1991	Staten, Roy G.	340/908.1
	D	US-5,589,984 A	12-1996	Schmidt et al.	359/603
	E	US-5,819,455 A	10-1998	Tsuda, Yoshinori	40/580
	F	US-5,863,109 A	01-1999	Hsieh, Chung-Tai	362/245
	G	US-5,974,712 A	11-1999	Kallionpaa, Veijo Ensio	40/612
	Н	US-6,092,318 A	07-2000	Arie et al.	40/547
	ı	US-6,264,334 B1	07-2001	Kushida, Kazumitsu	359/515
	J	US-6,762,689 B2	07-2004	Dechape, Michel L.	340/815.45
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					13.000
	0					
	Р					
	Q					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
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	w						
	x						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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